Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/974,554	LINDQVIST ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

SEARCHED				
Class	Subclass	Date	Examiner	
713	162	7/12/2006	ECT	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	7/12/2006	ECT